

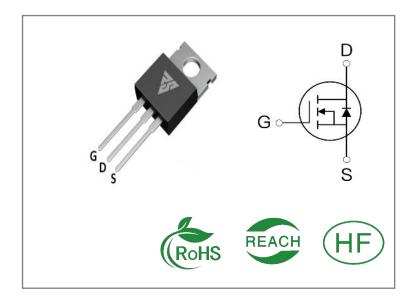
ID	R _{DS} (ON)(Typ)	VDSS
180A	2.0mΩ	30V

Applications:

- Load Switch
- PWM Applications
- Power Managment

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS30N180T	T0-220	RS30N180T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RS30N180T	Units
VDSS	Drain-to-Source Voltage	30	V
ID	Continuous Drain Current TC=25℃	180	
ID	Continuous Drain Current TC=100℃	114	Α
IDM	Pulsed Drain Current	720	
PD	Power Dissipation	88	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH,VDD = 15V, RG = 25Ω , Tj = 25° C	305	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	$^{\circ}$ C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS30N180T	Units	Test Conditions
RθJC	Junction-to-Case	2.1	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}{\rm C}$
RθJA	Junction-to- Ambient	35		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	30			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=30V,VGS=0 V
ICCC	Gate- to- Source Forward Leakage			100	- A	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
,	Static Drain- to- Source On-		2.0	2.6	mΩ	VGS=10V,ID=30A
RDS(on)	Resistance	3.3 4.3 mΩ VGS	VGS=4.5V,ID=20 A			
VGS(TH)	Gate Threshold Voltage	1.3	1.9	2.5	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		16		nS	VDS=15V ID=30A RG=3Ω VGS=10V
trise	Rise Time		30			
td(OFF)	Turn- OFF Delay Time		52			
tfall	Fall Time		20			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		5060			VGS= 0V
Coss	Output Capacitance		570		рF	VDS=15V
Crss	Reverse Transfer Capacitance		470			f=1.0MHz
Qg	Total Gate Charge		75			VDS= 15V
Qgs	Gate- to- Source Charge		9		nC	ID=20A
Qgd	Gate-to-Drain(" Miller") Charge		18			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current		-	180	Α	Integral pn- diode
ISM	Maximum Pulsed Current			720	Α	in MOSFET
VSD	Diode Forward Voltage			1.2	V	IS=30A,VGS=0V
trr	Reverse Recovery Time		24		nS	VGS=0V
Qrr	Reverse Recovery Charge		14		nC	IS=30A di/dt=100A/μs

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

Figure 1: Output Characteristics

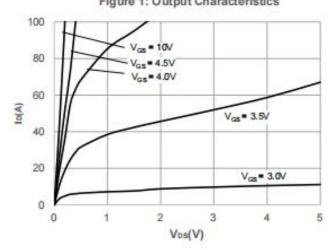


Figure 2: Typical Transfer Characteristics

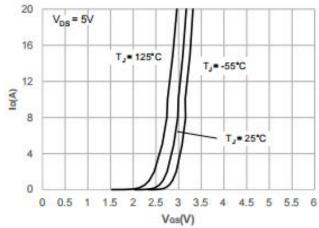


Figure 3: On-resistance vs. Drain Current

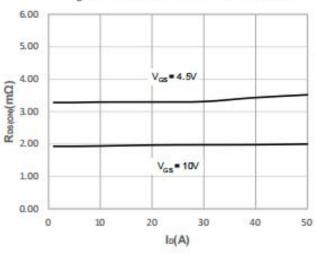


Figure 4: Body Diode Characteristics

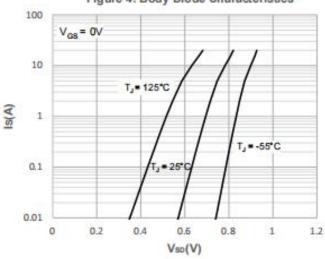


Figure 5: Gate Charge Characteristics

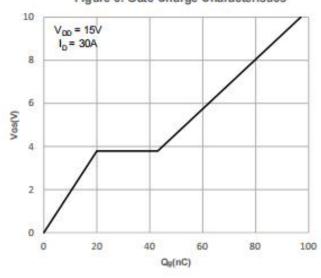
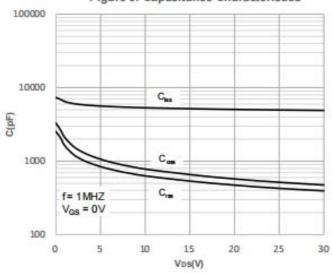


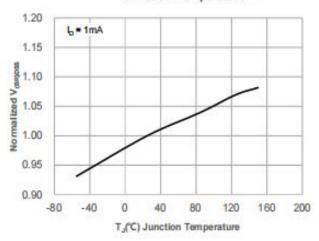
Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown voltage vs. Junction Temperature



Junction Temperature

Figure 8: Normalized on Resistance vs.

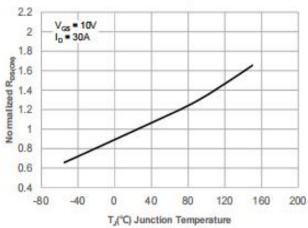


Figure 9: Maximum Safe Operating Area

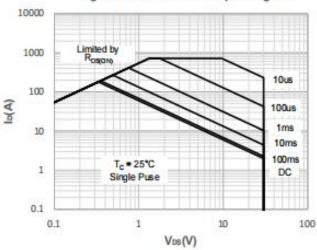


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

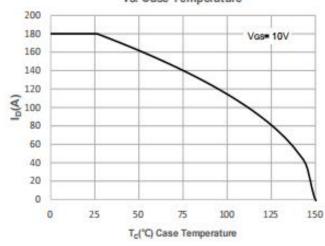


Figure 11: Normalized Maximum Transient Thermal Impedance

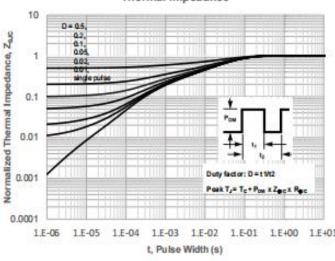
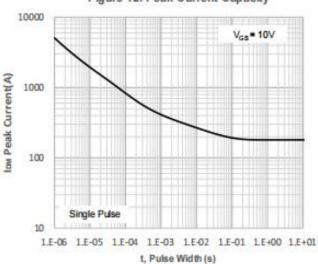


Figure 12: Peak Current Capacity



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Test ircuits and Waveforms

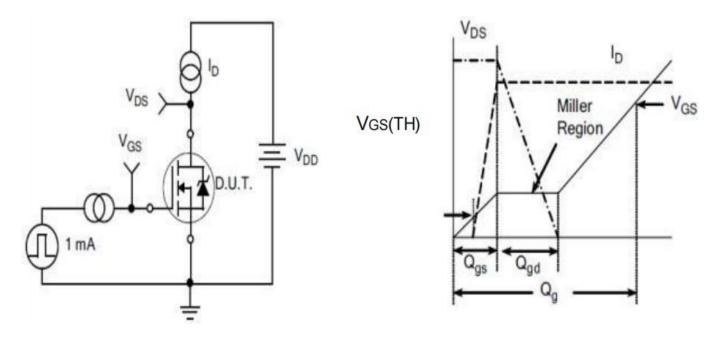


Figure A.
Gate Charge Test Circuit

V_{DS} V_{DS}

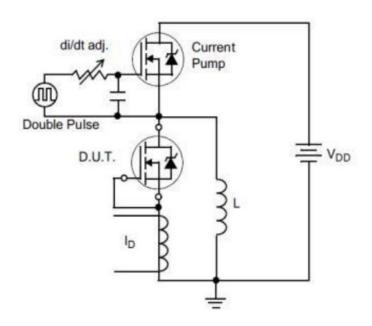
Figure C.
Resistive Switching Test Circuit

Figure B.
Gate Charge Waveform

Figure D.
Resistive Switching Waveforms



Test ircuits and Waveforms



 $di/dt = 100A/\mu A$ Q_{rr}

Figure E.Diode Reverse Recovery Test Circuit

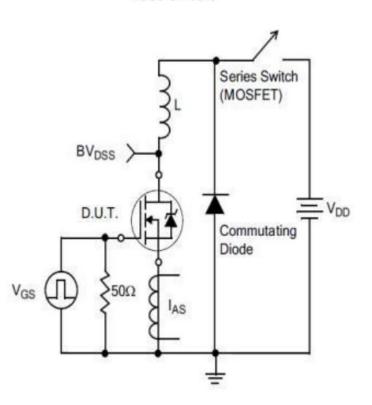


Figure F.Diode Reverse Recovery Waveform

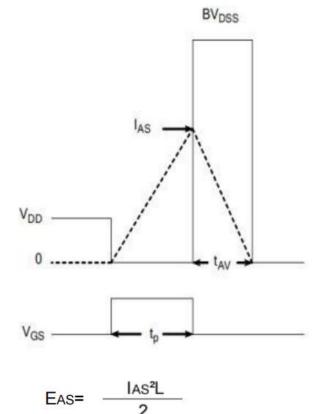


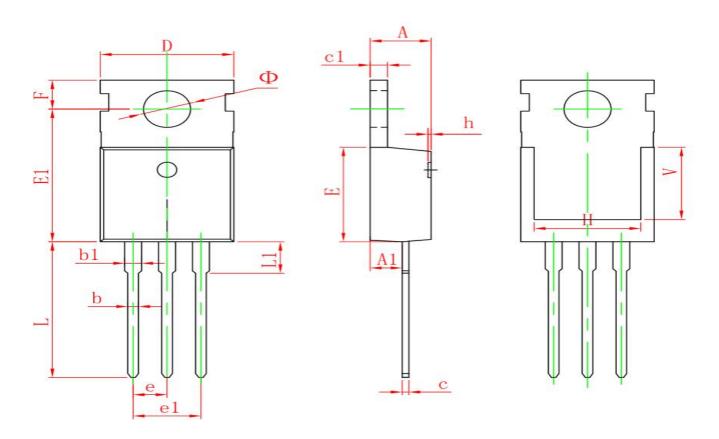
Figure G.Unclamped Inductive Switching Test Circuit

Figure H.Unclamped Inductive Switching Waveforms

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Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s In Inches	
Syllibol	Min.	Max.	Min.	Max.	
Α	4.400	4.600	0.173	0.181	
A1	2.250	2.550	0.089	0.100	
b	0.710	0.910	0.028	0.036	
b1	1.170	1.370	0.046	0.054	
С	0.330	0.650	0.013	0.026	
c1	1.200	1.400	0.047	0.055	
D	9.910	10.250	0.390	0.404	
E	8.950	9.750	0.352	0.384	
E1	12.650	13.050	0.498	0.514	
е	2.540	TYP.	0.100	TYP.	
e1	4.980	5.180	0.196	0.204	
F	2.650	2.950	0.104	0.116	
Н	7.900	8.100	0.311	0.319	
h	0.000	0.300	0.000	0.012	
L	12.900	13.400	0.508	0.528	
L1	2.850	3.250	0.112	0.128	
V	6.900	REF.	0.276 REF.		
Φ	3.400	3.800	0.134	0.150	



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